Content

Electrical Conductivity in Solids: Postulates of Classical free electron theory (CFET), Concept of Phonon, Matheissen's rule. Quantum free electron theory (QFET), Density of states in three dimensions (qualitative) and Fermi factor. Fermi energy: variation of Fermi factor with temperature. Band theory of solids (qualitative approach), electron concentration in metals at 0K. Intrinsic semiconductors: electronic concentration in conduction band and hole concentration (qualitative), Fermi level in intrinsic semiconductors, Extrinsic semiconductors: Variation of carrier concentration with temperature and Fermi energy with doping, Hall effect for metals and semiconductors, Numerical problems.

Introduction:

Conducting materials play a vital role in Engineering. It is very essential to know the electrical properties of materials for specific application of the materials. The properties of metals such as electrical conduction, thermal conduction, specific heat etc., are due to the free electrons or conduction electrons in metals. The first theory to explain the electrical conductivity of metals is Classical free electron theory and it was proposed by Drude in the year1900 and later developed and refined by Lorentz. Hence classical free electron theory is known as Drude-Lorentz theory.

Assumptions of Classical Free Electron Theory:

- 1. A metal is imagined as a three-dimensional ordered network of positive ions with the outermost electrons of the metallic atoms freely moving about the solid. The electric current in a metal, due to an applied field, is a consequence of drift velocity of the free electrons in a direction opposite to the direction of the field.
- 2. The free electrons are treated as equivalent to gas molecules and thus assumed to obey the laws of kinetic theory of gases. As per kinetic theory of gases, in the absence of the field the energy

associated with each electron at a temperature T is $\frac{3}{2}kT$, where k

is Boltzmann constant. It is related to the kinetic energy through the relation.

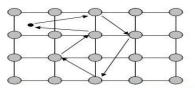
$$\frac{3}{2}kT = \frac{1}{2}mv_{th}^2$$

where v_{th} is the thermal velocity of the electrons.

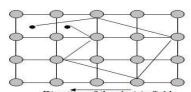
- 3. The electric potential due to the ionic core (lattice) is taken to be essentially constant throughout the metal.
- 4. The attraction between the free electrons and the lattice ions and the repulsion between the electrons are considered insignificant.

Drift Velocity

Initially the electrons in the metal which are in thermal equilibrium will move in random directions and often collide with ions with no net displacement. When electric field is applied, the equilibrium condition is disturbed and there will be net displacement in randomly moving free electron's positions, with time in a direction opposite to the direction of the field. This displacement per unit time is called **drift velocity** which will be constant for the free electrons in the steady state. This accounts for the current in the direction of the field.



Random motion without the electric field. In all probability the electron comes back to a position close to the earlier position if not the same position



Random motion in the presence of the electric field.

Notice the drift of the electron

If 'E' is the electric field applied to the metal, ' τ ' is mean collision time, then drift velocity for conduction electron in a metal is given by

$$v_d = \frac{eE}{m}\tau$$

Where 'e' and 'm' are charge and mass of electron respectively.

Current density (J):

It is the current per unit area of cross section of an imaginary plane held normal to the direction of current in a current carrying conductor.

i.e. J = I/A where A is the area of cross section.

Electric Field (E):

Electric field across homogeneous conductor is defined as the potential drop per unit length of the conductor.

If 'L' is the length of a conductor of uniform cross section and uniform material composition and 'V' is the potential difference between its two ends, then electric field 'E' is given by

$$E = V/L$$

Mean Free Path (λ):

It is the average distance travelled by the conduction electrons between successive collisions with lattice ions.

Mean Collision Time (τ):

It is the average time that elapses between two consecutive collisions of an electron with the lattice ions.

Relation between v, τ and λ .

If 'v' is the total velocity of the electrons, then the mean collision time ' τ ' is given by

$$\tau = \frac{\lambda}{v}$$

Resistivity (ρ):

For a material of uniform cross section, the resistance 'R' is directly proportional to length 'L' and inversely proportional to area of cross section 'A'

i.e.

$$R \alpha \frac{L}{A} \therefore R = \rho \left(\frac{L}{A}\right)$$

Where ' ρ ' is called resistivity. It is the property of the material and gives the measure of opposition offered by the material during the current flow in it.

$$\therefore \rho = \frac{RA}{L}$$

Conductivity (σ):

It is reciprocal of resistivity. It is a physical property that characterizes conducting ability of a material.

$$\sigma = \frac{1}{\rho} = \frac{L}{RA}$$

Relation between J, σ and E:

From ohms law

V=IR =
$$I \cdot \frac{\rho l}{A}$$

 $\frac{I}{A} = \frac{V}{l} \cdot \frac{1}{\rho}$
 $\frac{I}{A} = J \text{ and } \frac{1}{\rho} = \sigma$
 $J = \sigma E$

Expression for electric current in a conductor: (I)

$$I = nev_{d}A$$

n - Number of free electrons in unit volume of the conductor

 v_d - Drift velocity of electrons

A - Area of cross section of the conductor

e – Charge of an electron

Expression for Conductivity:

The current through the conductor is given by

$$I = neAv_d$$

We know that drift velocity (v_d) is given by

$$v_{d=} \frac{eE\tau}{m}$$

Substituting for v_d in the above equation

$$I = \frac{ne^2\tau}{m}AE$$

$$I = \frac{ne^2 \tau A}{m} (\frac{V}{L})$$
 where 'L' is the length of the conductor

Rearranging the terms of the above equation

$$\frac{m}{ne^2\tau} = \frac{A}{L} \left(\frac{V}{I}\right)$$

$$\frac{m}{ne^2\tau} = \frac{A}{L}R = \rho$$

$$\frac{1}{\rho} = \sigma, \text{Therefore } \sigma = \frac{ne^2\tau}{m}$$

Mobility of electrons:

Mobility of electrons (μ) is defined as the magnitude of drift velocity acquired by the electron in unit field.

i.e.
$$\mu = \frac{v_d}{E} = \frac{1}{E} \left(\frac{eE\tau}{m} \right) = \frac{eE}{m}$$

Failures of classical free electron theory:

Although electrical and thermal conductivity in metals can be explained successfully through classical free electron theory, it failed to account for many other experimental facts such as specific heat,

temperature dependence of conductivity and dependence of electrical conductivity on electron concentration.

- 1. The molar specific heat of a gas at constant volume is $Cv = \frac{3}{2}R$, where R is a universal constant. But the experimental value of electronic specific heat is $C_v = 10^{-4}RT$ which the classical theory could not explain. Also, the experimental value shows that the electronic specific heat is temperature dependent, whereas the classical free electron theory says that it is temperature independent.
- 2. The electrical conductivity of a metal is inversely proportional to temperature. According to classical free electron theory, electrical conductivity is inversely proportional to the square **root of** temperature, i.e., $\sigma \propto \frac{1}{\sqrt{T}}$.
- 3. Electrical conductivity is given as $\sigma = \frac{ne^2\tau}{m}$
 - According to classical electron theory electrical conductivity is directly proportional to the electron concentration. But monovalent metals like copper found to have high electrical conductivity than the divalent & trivalent metals like Zinc and Aluminium. Hence CFET fails to explain the observation.
- 4. Though metals are expected to exhibit negative Hall co-efficient since the charge carriers in them are electrons, some metals like zinc have positive Hall co-efficient. The free electron theory could not explain the positive Hall co-efficient of metals.

Concept of Phonon

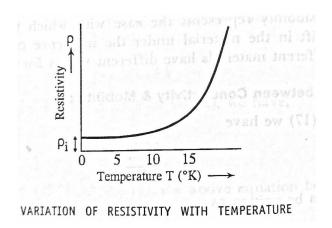
In condensed matter physics, a unit of vibrational energy that arises from oscillating atoms within the crystal is called phonon. Any solid crystal consists of atoms bound into a

specific repeating three-dimensional spatial pattern called a lattice.

Because the atoms behave as if they are connected by tiny springs, their own thermal energy or external forces make the lattice vibrate. A packet of these waves can travel throughout the crystal with a definite energy and momentum, so in quantum mechanical terms the waves can be treated as a particle, called a phonon. A phonon is a definite unit or quantum of vibrational mechanical energy, just as a photon is a quantum of electromagnetic or light energy.

Effect of Temperature and Impurity on Electron Resistivity of metals:

The variation of electrical resistivity ρ with temperature T in the low temperature region for sodium is as shown in the graph below.



Except for metals that are superconducting, the variation shown in the above graph applies to all conductors. The resistivity does not become

zero at T= 0 kelvin but has a small constant value. The resistivity increases slowly with temperature, later it assumes linear with a faster variation. The linearity in variation is continued throughout till the metal's melts.

In metals, the resistivity is attributed to the scattering of conduction electrons. It takes place under two mechanisms which give rise to two components of resistivity which are described below:

- 1) Resistivity ρ_{ph} due to scattering of electrons by lattice vibrations (phonons) increases with temperature. It is the resistivity exhibited by a pure specimen that is free of all defects, and hence called the ideal resistivity.
- 2) Resistivity ρ_i due to scattering of conduction electrons by the presence of impurities, and imperfections such as dislocation vacancies and grain boundaries. This type of scattering is independent of temperature and contributes to resistivity even at temperature T=0 kelvin. ρ_i is called residual resistivity.

If ρ is the total resistivity of the metal, then ρ is given by

The above equation is called **Matthiessen's rule**. It states that the total resistivity of a metal is the sum of resistivity due to phonon scattering which is temperature dependent and the resistivity due to scattering by impurities which is temperature independent.

Since the resistivity $\rho = \frac{1}{\sigma}$ and $\sigma = \frac{ne^2 \tau}{m}$, the equation for ρ can be written as,

$$\rho = \frac{m}{n\tau e^2}$$

If $\tau_{ph}\,$ is the mean collision time, assuming there is no scattering by impurities, then

$$\rho_{\rm ph} = \frac{m}{n\tau_{ph}e^2}$$

Similarly, if τ_i is the mean collision time assuming there is no scattering by lattice vibrations, then,

$$\rho_i = \frac{m}{n\tau_i e^2}$$

Therefore equation (1) can be written as,

$$\rho = \frac{m}{n\tau_{ph}e^2} + \frac{m}{n\tau_i e^2}$$

At low temperatures, the amplitude of vibration become small because of which, the scattering of electrons by lattice ions become less. This results in τ_{ph} becoming larger, and ρ_{ph} tends to zero at very low temperatures. It essentially means $\rho = \rho_i$ at very low temperatures.

Accordingly, it is observed from the graph that the resistivity has a residual value ρ_i at T=0 kelvin.

On the other hand, when the temperature becomes high, the amplitude of lattice vibration increases proportionately which results in large scale scattering of electrons. Consequently, the resistance curve takes an upswing, and the resistivity becomes linearly dependent on temperature. At sufficient high temperatures, the scattering effect due to phonons swamps the effect due to scattering by impurities. Thus, at temperatures near room temperatures, the resistivity curve is essentially linear.

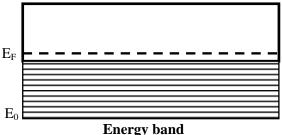
Assumptions of quantum free electron theory:

The main assumptions of quantum free electron theory are.

- The energy values of free electrons are quantized. The allowed 1. energy values are realized in terms of a set of energy levels.
- The distribution of electrons in the various allowed energy levels, 2. follows Pauli's Exclusion Principle.
- Distribution of electrons in energy states obey Fermi-Dirac 3. statistics.
- The free electrons travel in a constant potential inside the metal 4. but stay confined within its boundaries.
- 5. The attraction between the free electrons and lattice ions, the repulsion between the electrons themselves are ignored.

Fermi level and Fermi energy:

If we assume the number of electrons per unit volume as n_e then these electrons should be accommodated in the various energy levels. At absolute zero temperature, the electrons occupy the lowest available energy levels. The highest occupied level in metals at zero Kelvin is called as the Fermi level and the corresponding energy value of that level is called as the **Fermi energy**, it is denoted by E_F. Thus, at 0K all levels up to the Fermi level are occupied while the levels above it are vacant.



The dotted level is the Fermi level. Levels from E₀ up to E_F are occupied while levels above E_F are empty.

Fermi-Dirac statistics:

Under thermal equilibrium the free electrons are distributed in various available energy states. The distribution of electrons among the energy levels follows statistical rule known as Fermi-Dirac statistics.

Fermi-Dirac statistics is applicable to fermions. Fermions are indistinguishable particles with half integral spin. Since electron has half spin they obey Fermi-Dirac statistics, and they are called Fermions.

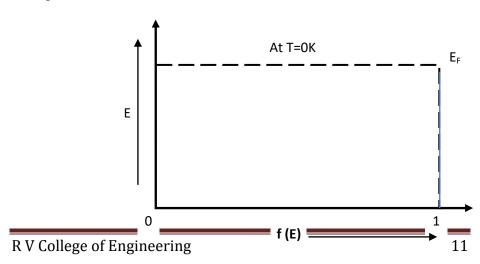
Fermi factor represents the probability that a quantum state with energy E is occupied by an electron, is given by Fermi-Dirac distribution function,

$$f(E) = \frac{1}{1 + \exp\left(\frac{E - E_F}{kT}\right)}$$

Where k is the Boltzmann's constant, T is the temperature in Kelvin, E is the energy and E_F is the Fermi energy.

Dependence of Fermi factor on temperature:

The dependence of Fermi factor on temperature at T=0K is given in the figure.



Case 1: the probability of occupation for $E < E_F$ at T = 0K

Substituting the value of T = 0K in the Fermi function we get

$$f(E) = \frac{1}{e^{(E-E_F/k_T)+1}} = \frac{1}{e^{-\infty}+1} = \frac{1}{0+1} = 1$$

f(E)=1 implies that all the levels below E_F are occupied by electrons.

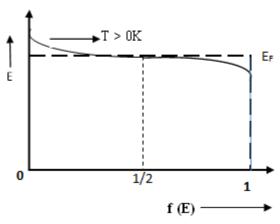
Case 2: the probability of occupation for $E > E_F$ at T = 0K.

Substituting the value of T = 0K in the Fermi function, we get

$$f(E) = \frac{1}{e^{(E-E_F/k_T)+1}} = \frac{1}{e^{\infty}+1} = \frac{1}{\infty} = 0.$$

This shows that all energy levels above E_F are vacant.

Case 3: Probability of occupation at temperature > 0K



- At ordinary temperatures, though the value of probability is 1 for E<< E_F, it starts decreasing from 1 as the values of E become closer to E_E
- 2. The value of f(E) become ½ at $E=E_F$. This is because at $E=E_F$

$$f(E) = \frac{1}{e^{(E-E_F/k_T)+1}} = \frac{1}{e^0+1} = \frac{1}{1+1} = \frac{1}{2}$$

- 3. For values just beyond E_F , f(E)>0
- 4. Further above $E > E_F$, the probability value falls off to zero rapidly.

It implies that the probability of occupancy of Fermi level at any temperature other than 0K is 0.5.

Hence Fermi level is defined as the energy level at which the probability of electron occupancy is half. Also, Fermi energy, E_F is the average energy possessed by the electrons which participate in conduction process in conductors at temperatures above 0K.

Density of states g (E):

The permitted energy levels for electrons in a solid will be in terms of bands. Each energy band spread over an energy range of few eV. The number of energy levels in each band will be extremely large and hence the energy values appear to be virtually continuous over the band spread. Each energy level consists of two states and each state accommodates only one electron. Therefore, energy level can be occupied by two electrons only, having opposite directions of spin. The exact dependence of density of energy states on the energy is realized through a function denoted as **g**(**E**) and is known as density of states function.

It is defined as, the number of available states per unit volume per unit energy interval.

The number of states lying in the range of energies between E and E+dE is given by

$$g(E)dE = \frac{4\pi}{h^3}(2m)^{3/2}E^{1/2}dE$$
.

Where E is the kinetic energy of the electron in the energy level E.

Carrier concentration in metals and Fermi energy at 0K

Number of free electrons /unit volume which possess energy in the range E and E+dE is given by $N(E) dE = g(E) \times dE \times f(E)$

The number of free electrons/unit volume of the material, i.e., n is equal to the total number of electrons that are distributed in various energy levels upto E_F . Thus, we have

$$n = \int_{E=0}^{E_F} N(E)dE \qquad n = \int_{E=0}^{E_F} g(E)f(E)dE$$
But f (E) =1, at T= 0K
$$n = \int_{E=0}^{E_F} g(E)dEx1$$

$$g(E) dE \text{ is given by,} \qquad g(E)dE = \frac{4\pi}{h^3} (2m)^{3/2} E^{1/2}dE$$

$$n = \frac{4\pi}{h^3} (2m)^{3/2} \int_{E=0}^{E_F} E^{1/2}dE$$

$$n = \frac{4\pi}{h^3} (2m)^{3/2} \frac{2}{3} (E_F)^{3/2}$$

$$n = \frac{8\sqrt{2}}{h^3} \pi m^{3/2} x \frac{2}{3} (E_F)^{3/2}$$

$$n = \frac{8\pi}{3h^3} (2m)^{3/2} (E_F)^{3/2}$$

This is the equation of concentration of electrons in a metal at 0K.

Expression for the Fermi energy at 0K is given by $E_F = \frac{h^2}{8m} (\frac{3n}{\pi})^{2/3}$

$$E_F = Bn^{2/3}$$

Where B=
$$(\frac{h^2}{8m})(\frac{3}{\pi})^{2/3}$$
 is a constant=5.85x10⁻³⁸J.

Success of Quantum Free Electron theory

- 1. The theory could successfully explain the specific heat capacity of metals.
- 2. It could also explain temperature dependence of electrical conductivity.
- 3. It explained the dependence of electrical conductivity on electron concentration.
- 4. It also explained photoelectric effect, Compton effect, Black body radiation, Zeeman effect etc.,

BAND THEORY OF SOLIDS:

The energy band structure of a solid determines whether it is a conductor, an insulator, or a semiconductor.

The electron of an isolated atom has certain definite energies such as 1s, 2s, 3p, 3s, etc. Between two consecutive allowed values of energy there is forbidden gap. As we bring together large number of identical atoms to form a solid, significant changes take place in the energy levels. The energy levels of each atom will interact with the other identical atoms. The wave functions of each atom will overlap and as a result the energy levels of each atom overlap slightly and split into several levels corresponding to the number of atoms. The split energy levels are very close to each other, and they form a narrow band known as energy band.

The range of energies possessed by electrons in a solid is known as energy band.

The energy band formed by the energy levels of the valence electrons is called valence band. The energy band immediately above the

valence band where the conduction electrons are present is called conduction band.

The separation between the upper level of valence band and the bottom level of conduction band is known as forbidden energy gap, E_g .

The forbidden energy gap is a measure of the bondage of valence electrons to the atom. The greater the energy gap more tightly valence electrons are bound. When energy is supplied, electrons from the valence band jump to the conduction band and thereby the material starts conducting.

SEMICONDUCTORS

Pure semiconductors are the materials having electrical conductivity greater than that of insulators but significantly lower than that of a conductor at room temperature. They have conductivity in the range of 10⁻⁴to 10⁴ S/m. The interesting feature about semiconductors is that they are bipolar, and current is transported by two types of charge carriers of opposite sign namely electrons and holes. The number of carriers can be drastically enhanced by doping the semiconductor with suitable impurities. The doped semiconductor which exhibits higher conductivity is called an extrinsic semiconductor. The conductivity of an extrinsic semiconductor depends on the doping level which is amenable to control. The current transportation in extrinsic semiconductor occurs through two different processes namely drift and diffusion. Pure semiconductors are of relatively less importance whereas extrinsic semiconductors are widely used in fabricating devices. These devices are more generally known as solid-state electronic devices.

INTRINSIC SEMICONDUCTORS

A semiconductor in an extremely pure form is known as an intrinsic semiconductor.

Intrinsic carriers in pure semiconductors

At room temperature in pure semiconductors, a single event of breaking of bonds leads to two carriers: namely electron and hole. The electron and hole are created as a pair & the phenomenon is called electron-hole pair generation. At any temperature T the number of electrons generated will be equal to the number of holes generated. If 'n' denotes number density of electrons in the conduction band & 'p' denotes the number of holes in the 'valence band then $n = p = n_i$ where, ' n_i ' is called intrinsic concentration or the intrinsic density After the generation, the carriers move independently; the electrons move in the conduction band & the holes move in the valence band. The motion of these two carriers is random in their respective band if no external field is applied.

Concept of Effective Mass of the Electron and Holes:

Consider an isolated electron of mass m and charge —e in an electric field of strength E. The electric force acting on it is —eE. The electron gets accelerated, then -eE = ma. However, an electron within a crystal is in a periodic potential due to positive ion cores. The neighbouring ions and electrons in the crystal do exert some force on the electron in a crystal. Then ma=-eE plus force due to neighbouring ions and electrons. Since the latter force is not known quantitatively, we can write the above equation as $m_e*a=-eE$ or $m_e*=-eE/a$ where m_e* is called the effective mass of the electron within the crystal. Thus, it is inferred that the effective mass of an electron depends on its location in the energy band. Electrons near the bottom of the conduction band have an effective mass which is almost equal to the effective mass of a free electron. Electrons near the bottom of the valence band have

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negative effective mass. The removal of an electron with a negative effective mass is identical to creating a particle of positive mass. Thus, hole is given the status of particle with positive effective mass m_h .

Carrier concentration in intrinsic semiconductor

The actual number of electrons in the conduction band is given by

$$n = \int_{E_c}^{\text{top of the band}} f(E)g_c(E)dE$$
(1)

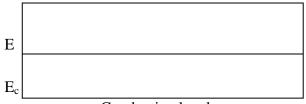
Since F-D function describes the probability of occupancy of energy state. Under thermal equilibrium condition, the electron concentration obtained from eqn. (1) is the equilibrium concentration.

As f(E) rapidly approaches zero for higher energies, the integral in eqn. (1) can be re-written as

$$n = \int_{E_c}^{\infty} f(E)g_c(E)dE$$

$$g_c(E) = \frac{4\pi}{h^3} (2m_e^*)^{\frac{3}{2}} (E)^{\frac{1}{2}} dE$$

Where, E is the kinetic energy of the electron.



Conduction band

In the above fig. the bottom edge of conduction band E_C corresponds to the potential energy of an electron at rest in conduction band. Therefore the quantity (E - E_C) represents the kinetic energy of conduction level electron at high energy level.

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$$g_c(E) = \frac{4\pi}{h^3} (2m_e^*)^{\frac{3}{2}} (E - E_c)^{\frac{1}{2}} dE$$
 (2)

$$n = \int_{E_c}^{\infty} \frac{4\pi}{h^3} (2m_e^*)^{\frac{3}{2}} \frac{(E - E_c)^{\frac{1}{2}}}{1 + \exp\left[\frac{(E - E_F)}{kT}\right]} dE$$
 (3)

As
$$E > E_F$$
: $e^{\frac{E-E_F}{kT}} >> 1:1 + e^{\frac{E-E_F}{kT}} \cong e^{\frac{E-E_F}{kT}}$

Therefore
$$\frac{1}{1+e^{\frac{E-E_F}{kT}}} \cong e^{\frac{-(E-E_F)}{kT}}$$

Using this equation in eqn. (3) we get

$$n = \frac{4\pi}{h^3} (2m_e^*)^{\frac{3}{2}} \int_{E}^{\infty} (E - E_c)^{\frac{1}{2}} e^{\frac{-(E - E_F)}{kT}} dE$$

Add and subtract E_c to the exponential term in the above equation.

$$n = \frac{4\pi}{h^3} (2m_e^*)^{\frac{3}{2}} e^{\frac{(E_F - E_c)}{kT}} \int_{E}^{\infty} (E - E_c)^{\frac{1}{2}} e^{\frac{-(E - E_c)}{kT}} dE$$

Let
$$E-E_c = x$$
 then $dx = dE$

Lower limit when $E=E_c$ $x=E_c-E_c=0$

Upper limit when $E=\infty$ $x = \infty - E_{c=\infty}$

Therefore
$$n = \frac{4\pi}{h^3} (2m_e^*)^{\frac{3}{2}} e^{\frac{(E_F - E_C)}{kT}} \int_0^\infty x^{\frac{1}{2}} e^{-ax} dx$$
 (4)

The integral is similar to standard integral.

The solution of eqn.(4) is given by

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$$\int_{0}^{\infty} x^{1/2} e^{-ax} dx = \frac{\sqrt{\pi}}{2a\sqrt{a}}, \quad \text{where a=1/kT}$$

$$\therefore n = \frac{4\pi}{h^{3}} \left(2m_{e}^{*}\right)^{3/2} e^{(E_{F} - E_{c})/kT} \left(\frac{\sqrt{\pi}}{2} (KT)^{3/2}\right)$$

Rearranging the term, we get

$$n = 2 \left[\frac{2\pi m_e^* kT}{h^2} \right]^{3/2} e^{-(E_C - E_F)/kT}$$
(5)

$$Let \ \ N_C = 2 \left[\frac{2\pi m_e^* kT}{h^2} \right]^{3/2}$$

$$\therefore n = N_C e^{-(E_C - E_F)/kT}$$
(6)

 N_c is temperature-dependent material constant known as effective density of states in the conduction band.

Expression for hole concentration in valence band

If f(E) is the probability for occupancy of an energy state at E by an electron, then probability that energy state is vacant is given by [1-f(E)]. Since hole represents the unoccupied state in valence band, the probability for occupancy of state at E by a hole is equal to probability of absence of electron at that level. The hole concentration in valence band is therefore given by

$$p = \int_{bottomband}^{E_{v}} [1 - f(E)] g_{v}(E) dE$$
(7)

E_{v}	
E	
_	

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Solving equation 7 we arrive at hole concentration, $p = N_v e^{\frac{-(E_F - E_v)}{kT}}$

where, N_v is temperature-dependent material constant known as effective density of states in the valence band.

Let
$$N_v = 2 \left[\frac{2\pi m_h^* kT}{h^2} \right]^{3/2}$$

Fermi level in intrinsic semiconductor

In an intrinsic semiconductor electron and hole concentrations are equal.

Therefore

$$n = p$$

$$N_c e^{\frac{-(E_C - E_F)}{kT}} = N_V e^{\frac{-(E_F - E_V)}{kT}}$$

Taking logarithm on both side and rearranging the term, we get

$$=>\frac{-(E_C-E_F)}{kT}=ln\left(\frac{N_V}{N_C}\right)-\frac{(E_F-E_V)}{kT}$$

Multiplying by kT, throughout

$$=>-E_C+E_F=kT\ln\left(\frac{N_V}{N_C}\right)-E_F+E_V$$

$$=>2E_F=kT\ln\left(\frac{N_V}{N_C}\right)+E_C+E_V$$

$$=>E_F=\left(\frac{E_C+E_V}{2}\right)+\frac{1}{2}kT\ln\left(\frac{N_V}{N_C}\right)$$

Substituting the values of N_V and N_C and after simplification we get

$$E_F = \left(\frac{E_C + E_v}{2}\right) + \frac{3}{4}kT \ln\left(\frac{m_h^*}{m_e^*}\right) \tag{1}$$

As kT is small and the effective mass m_e^* and m_h^* do not differ much, the second term in the eqn. (1) may be ignored.

If $m_e^* = m_h^*$, then we get

$$E_F = \left(\frac{E_C + E_v}{2}\right) \tag{2}$$

we can write eqn. (2) as

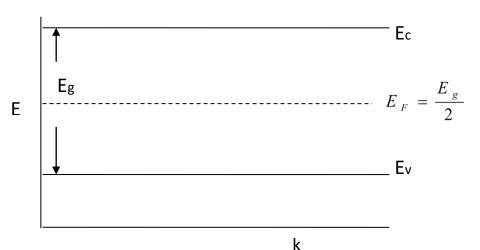
$$E_F = \left(\frac{E_C + E_v + E_v - E_v}{2}\right) = \frac{E_C - E_v}{2} + E_v$$

$$but \quad E_C - E_v = E_g$$

$$\therefore E_F = \frac{E_g}{2} + E_v$$

If top of the valence band E_v is taken as zero level, then $E_F = \frac{E_g}{2}$

Thus, Fermi level in the intrinsic semiconductor lies at the centre of the energy gap as shown below:



Extrinsic semiconductor

The intrinsic semiconductor has low conductivity which is not amenable to control. However, a judicious introduction of impurity atoms in an intrinsic semiconductor produces useful modification of its

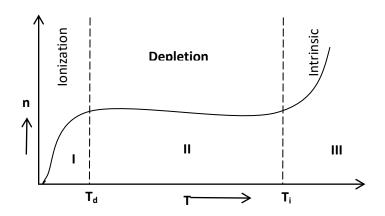
electrical conductivity. The method of introduction of controlled quantity of impurity into an intrinsic semiconductor is called doping. The impurity added is called dopant. The semiconductor doped with impurity atoms is called extrinsic semiconductor. There are two types of extrinsic semiconductor namely p-type & n-type which are produced depending on the group of impurity atoms.

n-type semiconductors are produced when pure semiconductors are doped with pentavalent impurity atoms such Phosphorous, Arsenic etc.

p-type semiconductors are produced when pure semiconductors are doped with trivalent impurity atoms such as Aluminum, Boron etc.

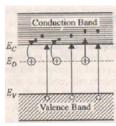
Temperature variation of carrier concentration in extrinsic semiconductor

The dependence of electron concentration on temperature for **n-type** semiconductor is as shown in the figure below.









At 0K the donor levels are filled which means that all the donor electrons are bound to the donor atoms. At low temperature, corresponding to region- I, there is not enough energy to ionize all the donors and not at all enough to break covalent bond. As temperature increases, the donor atoms get ionized and donor atoms go into the conduction band. The region-I is known as ionization region. Occasionally a covalent band maybe broken out, but number of such events will be insignificantly small. At about 100K all donor atoms are ionized, once all electrons from donor level are excited into conduction band, any further temperature increase does not create additional electrons and the curve levels off. The region II is called depletion region. In the depletion region the electron concentration in the conduction band is nearly identical to the concentration of dopant atoms.

If N_D is donor concentration, then $n_n = N_D$ (depletion region) where n_n – electron concentration in n-type

As temperature grows further, electron transitions from valence band to conduction band increases. At high temperature (region-III) the number of electron transition becomes so large that the intrinsic electron concentration exceeds the electron concentration due to donor. This region is therefore called intrinsic region. In intrinsic region, $n_n = n_i$

P type semiconductor

Similarly in p-type semiconductor, the acceptor levels are

vacant at 0K & valence band is full. As temperature increases in the ionization region, the electrons from the valence band jump into acceptor level. However, the electrons do not acquire enough energy to jump into conduction band levels. At the temperature T_s , the acceptor levels are saturated with electrons. The region- II lying between T_s (saturation temperature) and T_i is called the saturation region. In case of p-type materials within this temperature interval the hole concentration remains constant as thermal energy is not yet sufficient to cause electron transition from valence band to conduction band. In the saturation region, the hole concentration is equal to the acceptor impurity concentration. Thus $p_p = N_A$

With increase of temperature beyond T, electron transition due to intrinsic process commence & hole concentration due to intrinsic process far exceeds that due to impurity atoms.

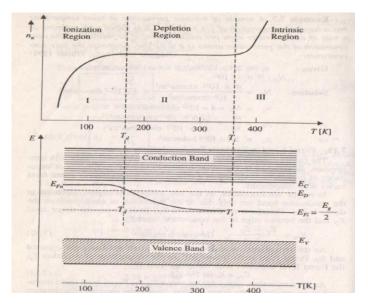
In region-III, $p_p = n_i$

Fermi level in extrinsic semiconductor

N-type semiconductor

The carrier concentration in extrinsic semiconductors varies with temperature as discussed earlier. It follows that the probability of occupancy of respective bands & position of Fermi level varies with temperature.

In n-type semiconductor, in low temperature region the electron in the conductor band is only due to the transition of electrons from donor levels. Therefore, Fermi level lies between the donor level E_D & the bottom edge of conduction band.



As temperature increases the donor level gradually gets depleted & the Fermi level shifts downward. At the temperature of depletion T_d , the Fermi level coincides with the donor level E_D

i.e.,
$$E_{Fn} = E_{D.}$$

As temperature increases further above T_d , the Fermi level shifts downward approximately in a linear fashion, though electron concentration in the conduction band remains constant. This is in accordance with the relation $E_{F_n} = \frac{E_c + E_D}{2} - \frac{kT}{2} \ln \frac{N_c}{N_c}$.

At temperature T_i , where intrinsic process contributes to electron concentration significantly, the Fermi level approaches the intrinsic value $E_{Fi} = E_g/2$. With further increase in temperature the behaviour of extrinsic semiconductor transitions into that of an intrinsic type & Fermi level stay at E_{Fi} . Thus

$$E_{Fn} = E_{Fi} = E_{g}/2$$
.

P-type semiconductor

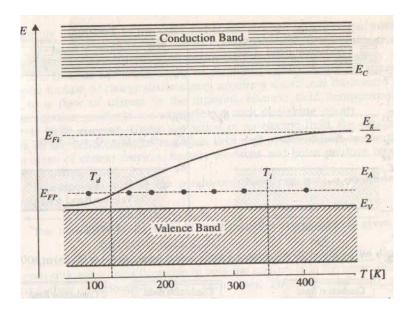
In case of p-type semiconductor the Fermi level E_{Fp} rises with increasing temperature from below the acceptor level to intrinsic level E_{Fi} as shown in fig 2.

$$\therefore E_{Fp} = \frac{E_A + E_v}{2}$$
 (ionization region)

As temperature increases further above T_s, the Fermi level shifts downward approximately in linear fashion, though hole concentration in the valence band remains constant. This is in accordance with the

relation
$$E_{F_p} = \frac{E_v + E_A}{2} + \frac{kT}{2} \ln \frac{N_v}{N_A}$$
.
 $E_{Fp} = E_A$ at T=T_s

And
$$E_{Fp} = E_g/2$$
.



Effect of variation of impurity concentration: n-type semiconductor

The addition of donor impurity to an intrinsic semiconductor leads to the formation of discrete donor level below the bottom edge of conduction band. At low impurity concentrations the impurity atom is spaced far apart & do not interact with each other. With an increase in the impurity concentration the impurity atom separation in the crystal decreases & they tend to interact. Consequently, the donor level also undergoes splitting & form energy band below the conduction band. The larger the doping concentration, the broader is the impurity band & at one stage it overlaps with the conduction band.

The broadness of donor levels into a band is accompanied by a decrease in the width of forbidden gap & also the upward displacement of Fermi level. The Fermi level moves closer & closer to the conduction band with increasing impurity concentration & finally moves into the conduction band as donor band overlaps the conduction band.

In similar way, in p-type semiconductor, the acceptor level broadens and forms into a band with increasing impurity concentration which ultimately overlaps the valence band. The Fermi level moves down closer to the valence band and finally at high impurity concentration it will shift in to valence band.

UNIT 4 ELECRICAL CONDUCTIVITY OF SOLIDS QUANTUM PHYSICS FOR ENGINEERS

Computer Science Stream- (CS, AI, CY, CD, IS, and BT)

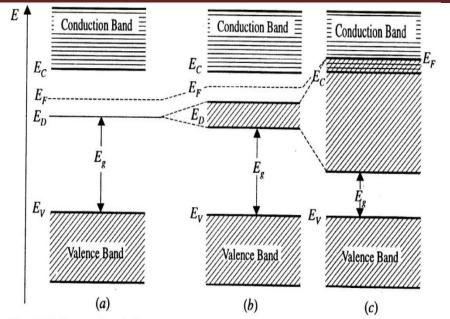


Fig. 7.24. Energy band diagrams of an n-type semiconductor at three different levels of doping; (a) low level doping; (b) medium doping; (c) heavy doping.

HALL EFFECT:

When a transverse magnetic field 'B' is applied perpendicular to current carrying conductor, a potential difference is developed across the specimen in a direction perpendicular to both current and the magnetic field. This phenomenon is called the Hall effect. The Voltage so developed is called Hall voltage.

Hall effect helps to i) determine the sign of charge carrier in the material 2) determine the charge carrier concentration and iii) determine the mobility of charge carrier if conductivity of material is known. Hall effect measurement showed that the negative charge carriers, that is the electrons are responsible for conduction in metal

and it also showed that there exist two types of charge carriers in a semiconductor.

To explain Hall Effect in **metals** (conductor), consider a rectangular plate of a metal having, width w and thickness t. When, potential difference is applied across its ends, a current 'I' flows through it along x direction that is opposite to the direction of flow of electrons. The current passing through the metal is given by.

$$I = nAev_d \tag{1}$$

where n- concentration of electrons

A- Area of cross section of end face

e- charge on the electron

v_d- drift velocity of electron

n – concentration of electrons

Therefore $\mathbf{v_d} = \mathbf{I/nAe} = \mathbf{I/nwte}$

where A=wt (w is the width of the sample and t is the thickness of the sample)

(2)

Any plane perpendicular to current flow direction is an equipotential surface. Therefore, potential difference between front and rare faces is zero. If magnetic field is applied normal to crystal surface and to the current flow, a transverse potential difference is produced between the faces $F \& F^{\prime}$. It is called Hall voltage V_H .

In the absence of magnetic field B, the charge carriers move in a direction parallel to faces F & F'. On the application of magnetic field B, the Lorentz force comes into existence and this force deflects the electrons sideways. The magnitude of this force is given by.

$$F_L = e B v_d$$

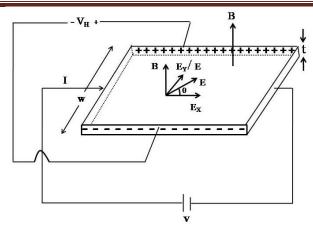


Fig. Hall effect in conductors

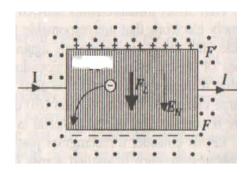


Fig. Direction of magnetic force and Hall field in a conductor

In the absence of magnetic field B, the charge carriers move in a direction parallel to faces F & F' as shown in the above figure. On the application of magnetic field B, the Lorentz force comes into existence and this force deflects the electrons sideways due to the magnetic force F_L . The magnitude of this force is given by.

$$F_L = e B v_d$$

Because of this force, electrons will move towards the front face F and pile up there. Initially the material is electrically neutral everywhere. However, as electrons pile up on the front side, a corresponding

equivalent positive charge is left on the rare face F'. As a result, an electric field is produced across F & F'. The direction of electric field (E_H) will be from rare face to front face. A condition of equilibrium is reached when force (F_H) due to transverse electric field E_H , balances the Lorentz force (F_L) . The transverse electric field E_H is known as Hall field.

At equilibrium condition

$$F_{L} = F_{H} \tag{3}$$

$$F_H = e E_H = e (V_H/w)$$
 (4)

Substituting for F_L and F_H in eqn (3) we get

$$eBv_d = eV_H/w (5)$$

Substituting for v_d from equation (2) in equation (5)

$$\frac{BI}{nwte} = \frac{V_H}{w} \tag{6}$$

Hall voltage
$$V_H = \frac{BI}{net}$$
 (7)

Reciprocal of Carrier charge density is called $Hall\ co$ -efficient R_H

$$R_H = 1/ne$$

Equation (6) can be written as
$$\frac{1}{ne} = \left(\frac{V_H}{B}\right) \frac{t}{I}$$

$$D = V_H t$$

$$R_{\rm H} = \frac{V_H t}{BI}$$

The Hall voltage can be measured with a voltmeter with the direction of magnetic field & current depicted in fig, the sign of Hall voltage is negative.

The charge carrier concentration is given by.

$$n = -\frac{1}{R_H e} = -\frac{BI}{V_H te}$$

The number of charge carriers in metals is of the order of 10^{28} /m³ and in n or p type semiconductors it ranges from 10^{19} - 10^{23} /m³.

HALL EFFECT IN SEMICONDUCTORS:

The Hall effect in semiconductors is similar to that of metals. In case of metals and n -type semiconductors the majority charge carriers are electrons and hence the same derivation holds good for both. In a p-type semiconductor the only difference is that majority charge carriers are **holes**, with positive charge, hence with slight modifications we can obtain the Hall effect parameters following the method used for metals.

Let us consider a rectangular plate of p-type semiconductor. When potential difference is applied across its ends, a current 'I' flows through it along x direction. If holes are majority charge carriers in p-type semiconductors, then the current is given by

$$\mathbf{I} = \mathbf{pAev_d} \tag{1}$$

Where p- concentration of holes

A-Area of cross section of end face

e- charge on the hole

v_d- drift velocity of holes

therefore
$$v_d = I/pAe = I/pwte$$
 (2)

Any plane perpendicular to current flow direction is an equipotential surface. Therefore, potential difference between front and rare faces is zero. If magnetic field is applied normal to crystal surface and also to the current flow, a transverse potential difference is produced between the faces F & F'. It is called Hall voltage V_H .

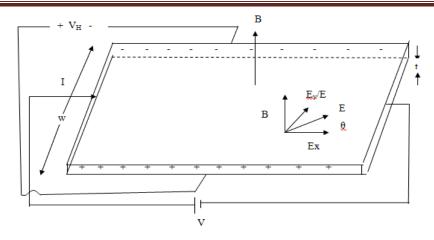
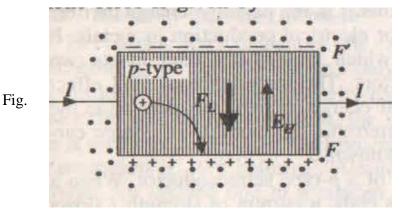


Fig. Hall effect in p type semi conductor



Direction of magnetic force and Hall field in p-type semiconductor

Before the application of magnetic field B, the holes move in an orderly way parallel to faces F & F'. On the application of magnetic field B, the holes experience a sideway deflection due to the Lorentz force F_L . The magnitude of this force is given by

$$F_L = e B v_d$$

Because of this force, holes are deflected towards the front face F and pile up there. Initially the material is electrically neutral everywhere. However, as holes pile up on the front side, a corresponding equivalent negative charge is left on the rare face F'. As a result an electric field is produced across F & F'. The direction of electric field will be from front face to rare face. It is such that it opposes the further pile up of holes on the front face F. A condition of equilibrium is reached when F_H due to transverse electric field E_H balances the Lorentz force. The transverse electric field E_H is known as Hall field.

In equilibrium condition

$$F_{L} = F_{H}$$

$$F_{H} = e E_{H} = e(V_{H}/w)$$
 (3)

Substituting for F_L and F_H in eqn (3) we get

$$eBv_d = eV_H/w$$
 (5)

Substituting for v_d from equation (2) in equation (5)

$$\frac{BI}{pwte} = \frac{V_H}{w} \tag{6}$$

Hall voltage
$$V_H = \frac{BI}{pet}$$
 (7)

Reciprocal of Carrier charge density is called $Hall\ co\text{-efficient}\ R_H$

$$R_H = 1/pe$$

Equation (6) can be written as

$$\frac{1}{pe} = \left(\frac{V_H}{B}\right) \frac{t}{I} \qquad \qquad R_H = \frac{V_H t}{BI}$$

The Hall voltage is a real voltage & can be measured with a voltmeter with the direction of magnetic field & current depicted in this fig, the sign of Hall voltage is +ve.

For n-type semiconductor Hall voltage will be –ve, when the direction of current is same as in the fig. Therefore by knowing the sign of Hall voltage the type of semiconductor & the sign of the majority charge carriers will be known.

The carrier concentration is given by.

$$p = \frac{1}{R_{H}e} = \frac{BI}{V_{H}te}$$

In case of n-type semiconductor

$$n = -\frac{1}{R_{H}e} = -\frac{BI}{V_{H}te}$$

SOLVED NUMERICALS:

1. What is the probability of a level lying 0.01 eV below the Fermi level not being occupied by electrons at T = 300K?

Solution:

Probability of electrons not being occupied = 1-f(E) = 1- $(e^{(E-E_F)^{/k}_B}^T + 1)^{-1}$ = 1 - $(e^{0.01/0.026} + 1)^{-1}$ = 1-[1/(1.47 + 1)] = 0.405

2. Find the temperature at which there is 1% occupancy probability of a state 0.5 eV above Fermi energy.

Solution:

$$f(E) = 0.01 = 1/[e^{(E-E_F)/k}_B^T + 1]$$
 for E-E_F= 0.5 eV Solving we get $0.01 = 1/[e^{5797/T} + 1]$.
Thus $e^{5797/T} = 1/0.01 - 1 = 99$.
Taking log we get, $T = 5797/4.595 = 1261.1$ K

3. The effective mass of holes in a material is 4 times that of electrons. At what temperature would the Fermi energy be shifted by 10% from the middle of the forbidden energy gap? Given band gap = 1 eV.

Solution:
$$E_{F=}(E_C + E_V)/2 + (3kT/4) \log(m_h/m_e)$$

Fermi level is shifted by 10% = 0.1 eV.

Originally Fermi energy was 0.5 eV above E_V.

Now it is 0.5+0.1 = 0.6 eV above E_F.

$$(E_V + 0.6) \text{ eV} = (E_C + E_V)/2 + (3kT/4)\log(4) ----(1)$$

And
$$(E_V + 0.5) \text{ eV} = (E_C + E_V)/2$$
 -----(2)

Subtracting 2 from 1 we get $0.1 \text{ eV} = (3kT/4)\log(4)$

$$0.1602 \times 10^{-19} \text{J} = (3 \times 1.38 \times 10^{-23} \times \text{T/4}) \cdot 0.6021.$$

$$T = 1116K$$

4. For an intrinsic semiconductor with gap width E_g =0.7eV. Calculate the concentration of intrinsic charge carriers at 300K assuming that m_e *= m_o (rest mass of electron).

$$n_i = 2 \left\lceil \frac{2\pi mkT}{h^2} \right\rceil^{3/2} e^{-Eg/2kT}$$
 $n_i = 33.49 \times 10^{18} / \text{m}^3$

5. The Fermi level in silver is 5.5eV at 0K. Calculate the number of free electrons per unit volume and the probability occupation for electrons with energy 5.6eV in silver at the same temperature.

Solution:

$$E_{F_0} = \left[\frac{h^2}{8m}\right] \left[\frac{3}{\pi}\right]^{2/3} n^{2/3} \qquad n = 5.84x 10^{28} m^{-3}.$$

6. Calculate the probability of an electron occupying an energy level 0.02eV above the Fermi level at 200K and 400K in a material.

$$f(E) = \frac{1}{1 + e^{\frac{E - E_F}{kT}}}$$
$$f(E) = \frac{1}{1 + e^{\frac{0.02x1.6x10^{-19}}{1.38x10^{-23}x200}}} = 0.24$$

$$f(E) = 0.36$$
 at 400 K.

7. A semiconducting material 12 mm long, 5 mm wide and 1 mm a magnetic flux density of 0.5 Wb/m² applied thick has perpendicular to the largest faces. A current of 20 mA flows through the length of the sample, and the corresponding voltage measured across its width is 37µV. Find the Hall coefficient of the semiconductor.

Solution:

Hall coefficient $R_H = E_v/J_xB_z = -1/ne$.

Since
$$E_y = V_y/w$$
, $R_H = V_y/wJ_xB_z$

Thus $R_H = (37x10^{-6}x10^{-3})/(20x10^{-3}x0.5) = 3.7x10^{-6} \text{ m}^3\text{C}^{-1}$

S. No	Sample Questions	
1.	An electron is accelerated by an electric field of 4V/cm, is	
	found to have mobility 8x 10 ⁻³ m ² / Vs. What is its drift	
	velocity?	
2.	How many valence electrons will a donor impurity has in a n-	
	type semiconductor?	
3.	What is a hole in context of semiconductors?	
4.	In Hall effect experiment what is the polarity of Hall voltage for	
	a n-type semiconductor?	
5.	What will be the Fermi velocity of an electron in copper if	
	Fermi energy $(E_F) = 6 \text{ eV}$?	
6.	At 300K, if probability for occupancy of an energy state E by an	
	electron is 0.75, calculate probability for occupancy of the same	
	state by a hole?	
7.	Write any two assumptions of Drude-Lorentz theory?	
8.	Sketch the graph of Fermi factor $f(E)$ verses E for the case $E=E_F$	
	at at T> 0K in metals.	
9.	Define density of states in metals.	
10.	Write an expression for density of states in metals.	
11.	Sketch the variation of fermi level with temperature for n type	
	semiconductor.	
12.	What are Fermions?	
13.	Outline the phenomenon of Hall effect in materials.	
14.	For silicon semiconductor with band gap 1.12eV, determine the	
	position of the Fermi level at 300K if m _e *=0.12m _o and	
	$m_h^* = 0.28 m_o.$	
15.	Distinguish between intrinsic and extrinsic semiconductors.	
16.	Find the probability that energy level at 0.2 eV below Fermi	
R V College of Engineering 39		

UNIT 4 ELECRICAL CONDUCTIVITY OF SOLIDS

What is the value of Fermi function when $E=E_f$ at T>0K?

Mention any two demerits of classical free electron theory.

Find the probability of a level lying 0.01 eV below the Fermi

What is the effect of increase of impurity concentration on band

QUANTUM PHYSICS FOR ENGINEERS Computer Science Stream- (CS, AI, CY, CD, IS, and BT)
level being occupied at temperature 1000K?

gap in extrinsic semiconductors?

17.

18.

19.

20.

21.

experiment?

22.	With neat sketch, show the Fermi level position in p-type
	semiconductor.
23.	What is Fermi factor in Fermi Dirac distribution?
24.	Find the relaxation time of conduction electrons in a metal if its
	resistivity is $2.5 \times 10^{-8} \Omega m$ and it has 5×10^{28} conduction

What is the magnitude of Lorentz force in Hall effect

level being occupied by electrons at T = 0K?

electrons/m³ Sketch the position of Fermi level at 0K in a band diagram of a 25.

- n-type semiconductor, at low doping 26. Find the Fermi velocity of conduction electron if the Fermi energy of silver is 8eV.
- 27. Determine the probability of occupancy of an energy level situated 0.05eV above the Fermi energy at temperature of 0K 28. Write an expression for carrier concentration of p-type semiconductor.
- Write any two postulates of classical free electron theory of 29. solids. Give the relation between electrical conductivity and mobility 30. of charge carriers in a conductor. 31. If a system is composed of indistinguishable, half integral spin
- particles and obeys Pauli exclusion principle, then what statistics is obeyed by the system? 32. What is the value of the Fermi factor for metals at room

Plot variation of Fermi factor with temperature in a metal.

Give expression for Fermi level at 0 k in an intrinsic

Distinguish between free electron theory and band theory of solids in terms of influence of lattice on the electron moving in

temperature?

a metal.

semiconductor.

33.

34.

35.

	semiconductor.
36.	Find the temperature at which there is 1% probability that a
	state with energy 0.5 eV above Fermi energy is occupied?
37.	What is Hall Effect?
38.	Sketch the variation in the energy of the Fermi level in a 'n'
	type semi-conductor as a function of temperature?
39.	A wire of diameter 0.2 meter contains 10^{28} free electrons per
	cubic meter. For an electric current of 10A, calculate the drift
	velocity for free electrons in the wire?
40.	The fermi level in an intrinsic semi-conductor is at .25 eV.
	What is the width of the band gap?
41.	The fermi energy for an intrinsic semiconductor is at 5 eV. At
	0K, calculate the probability of occupation of electrons at E=
	5.5eV?
42.	A sample of silicon is doped with 10^7 phosphorous atoms/cm ³ .
	Find the Hall voltage, if the sample is $100\mu m$ thick, $I_x=1$ mA
	and $B_z = 10^{-5} \text{ Wb/m}^2$?
43.	Write any one drawback of classical free electron theory?
44.	Write the relation for specific heat of a metal as per quantum
	free electron theory
45.	Write the condition at which the value of $f(E) = 1$ at 0 K.
46.	Mention any two assumptions of quantum free electron theory.
47.	Find the relaxation time of conduction electrons in a metal of
	resistivity $1.54 \times 10^{-8} \Omega m$. If the metal has 5.8×10^{28} conduction
	electrons per m ³ .

UNIT 4 ELECRICAL CONDUCTIVITY OF SOLIDS QUANTUM PHYSICS FOR ENGINEERS Computer Science Stream- (CS, AI, CY, CD, IS, and BT) Find the probability with which an energy level 0.02 eV below

Fermi level will be occupied at room temperature of 300K.

	r
49.	A copper strip of 2.0 cm wide and 1.0 mm thick is placed in a
	magnetic field of 15000 gauss. If a current of 200 A is setup in
	the strip with the Hall voltage appears across the strip is found
	to be 0.18 V. calculate the Hall coefficient.
50.	Which statistical rule is obeyed by electrons in quantum free
	electron theory?
51.	Where does the Fermi level lie in case of n type semiconductor
	with high impurity concentration?
52.	Electron concentration in a semiconductor is 10^{20} m ³ . Calculate
	Hall coefficient?
53.	What is doping in semiconductors?
54.	Evaluate the probability of occupation of an energy level 0.4 eV
	below the Fermi energy level in metal at zero Kelvin.
55.	If the probability of absence of electron in an energy level of
	valance band of semiconductor is 0.65 what is the probability of

In the band diagram of a p-type semiconductor show the

position of the Fermi level when the doping concentration is

temperature in Kelvin where n_e is the electron concentration in

Write the postulates of classical free electron theory and explain

Graphically show the variation of ln(n_e) with increasing

59. Write the success of Quantum free electron theory.
60. Explain the variation of Fermi factor in metals with temperature.
61. Explain Fermi Dirac distribution function. Show that at temperatures above 0K probability of occupancy of Fermi level

48.

56.

57.

58.

low?

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an intrinsic semiconductor.

occupation in the same level by a hole?

the failures of classical free electron theory.

computer Science Stream (65,111, 61, 62,13, and 21)		
	in metals is 50%.	
62.	Derive an expression for the electron concentration in metals at	
	0K.	
63.	Derive an expression for the electron concentration in intrinsic	
	semiconductor.	
64.	Show that Fermi level of an intrinsic semiconductor lies in the	
	middle of the band gap.	
65.	With a neat sketch explain the variation of Fermi level in an n-	
	type semiconductor with the increase in temperature.	
66.	What is Hall Effect? Arrive at an expressions for Hall voltage	
	in an n-type semiconductor.	
67.	Explain the change of band gap with variation in the doping	
	concentration of an n type semiconductor.	
68.	Explain the variation the carrier concentration with increase in	

Appendix

Expression for hole concentration in valence band

temperature in an n type semiconductor.

If f(E) is the probability for occupancy of an energy state at E by an electron, then probability that energy state is vacant is given by [1-f(E)]. Since hole represents the unoccupied state in valence band, the probability for occupancy of state at E by a hole is equal to probability of absence of electron at that level. The hole concentration in valence band is therefore given by

$$p = \int_{-\infty}^{E_{v}} \left[1 - f(E)\right] g_{v}(E) dE \tag{7}$$

UNIT 4 ELECRICAL CONDUCTIVITY OF SOLIDS QUANTUM PHYSICS FOR ENGINEERS

Computer Science Stream- (CS, AI, CY, CD, IS, and BT)

E_v E

Valence band

1-f(E) rapidly approaches to zero for lower energy levels, the above equation rewritten as

$$p = \int_{-\infty}^{E_{v}} [1 - f(E)] g_{v}(E) dE$$

$$p = \int_{-\infty}^{E_{v}} [1 - f(E)] \frac{4\pi}{h^{3}} (2m_{h}^{*})^{\frac{3}{2}} (E_{v} - E)^{\frac{1}{2}} dE$$

Now
$$1 - f(E) = 1 - \frac{1}{1 + e\left(\frac{E - E_F}{kT}\right)} = \frac{e^{\frac{E - E_F}{kT}}}{1 + e\left(\frac{E - E_F}{kT}\right)}$$
 (8)

For E<E_F (E-E_v) is negative. Therefore $e^{\frac{E-E_F}{kT}} \cong 0$

Therefore
$$1 + e \left(\frac{E - E_F}{kT} \right) \cong 1$$

and equation 8 reduces to 1- f(E)= $e^{\frac{-(E_F-E)}{kT}}$

$$p = \int_{-\infty}^{E} \frac{4\pi}{h^3} (2m_h^*)^{\frac{3}{2}} (E_v - E)^{\frac{1}{2}} e^{-\frac{(E_F - E)}{kT}} dE$$

$$p = \frac{4\pi}{h^3} (2m_h^*)^{\frac{3}{2}} e^{-\left(\frac{E_F - E_v}{kT}\right)} \int_{-\infty}^{E_v} (E_v - E)^{\frac{1}{2}} e^{-\left(\frac{E_v - E}{kT}\right)} dE$$

Let E_v -E=x then -dE = dx or dE = -dX

UNIT 4 ELECRICAL CONDUCTIVITY OF SOLIDS QUANTUM PHYSICS FOR ENGINEERS

Computer Science Stream- (CS, AI, CY, CD, IS, and BT)

LowerLt UpperLt
$$x = E_{v} - (-\infty) E = E_{v}$$

$$x = E_{v} + \infty \qquad x = E_{v} - E_{v} = 0$$

$$x = \infty \qquad x = 0$$

$$p = \frac{4\pi}{h^{3}} (2m_{h}^{*})^{\frac{3}{2}} e^{-\left(\frac{E_{F} - E_{v}}{kT}\right)} \int_{-\infty}^{0} (E_{v} - E)^{\frac{1}{2}} e^{-\left(\frac{E_{v} - E}{kT}\right)} (-dE)$$

$$p = \frac{4\pi}{h^{3}} (2m_{h}^{*})^{\frac{3}{2}} e^{-\left(\frac{E_{F} - E_{v}}{kT}\right)} \int_{-\infty}^{\infty} (E_{v} - E)^{\frac{1}{2}} e^{-\left(\frac{E_{v} - E}{kT}\right)} dE$$

Above equation is of the standard form $\int_{0}^{\infty} x^{\frac{1}{2}} e^{-ax} dx = \frac{\sqrt{\pi}}{2a\sqrt{a}} \quad \text{where } E_{v}$

$$E=x \text{ and } a = \frac{1}{kT}$$

$$p = \frac{4\pi}{h^3} (2m_h^*)^{\frac{3}{2}} e^{-\left(\frac{E_F - E_v}{kT}\right)} \frac{\sqrt{\pi}}{2} (kT)^{\frac{3}{2}}$$

$$p = 2\left[\frac{2\pi m_h^* kT}{h^2}\right]^{\frac{3}{2}} e^{-\frac{(E_F - E_v)}{kT}}$$

$$Let \ N_v = 2\left[\frac{2\pi m_h^* kT}{h^2}\right]^{3/2}$$

where N_v is temperature-dependent material constant known as effective density of states in the valence band.

$$p = N_{v}e^{\frac{-(E_{F}-E_{v})}{kT}}$$

Expression for the band gap of a Semiconductor:

The band gap is the energy separation between the conduction band and the valence band of a semiconducting material.

The conductivity of an intrinsic semiconductor is given by $\sigma = n_i e \mu_e + n_i e \mu_h$

$$\sigma = n_i e(\mu_e + \mu_h)$$

Substituting the value of n_i, we get

$$\sigma = 2 \left[\frac{2\pi kTm}{h^2} \right]^{\frac{3}{2}} x \left[\frac{m_e^* m_h^*}{m^2} \right]^{\frac{3}{4}} \exp \left[\frac{-E_g}{2kT} \right] e(\mu_e + \mu_h)$$

The above equation can be written as $\sigma = A \exp \left[\frac{-E_g}{2kT} \right]$

Where
$$A = 2 \left[\frac{2\pi kTm}{h^2} \right]^{\frac{3}{2}} x \left[\frac{m_e^* m_h^*}{m^2} \right]^{\frac{3}{4}} e(\mu_e + \mu_h)$$

As $\sigma = \frac{1}{\rho}$: $\rho = B \exp \left[\frac{E_g}{2kT} \right]$ We know that $\rho = \frac{RA}{l}$ then

$$R = B \frac{l}{A} \exp \left[\frac{E_g}{2kT} \right]$$

$$R = C \exp \left[\frac{E_g}{2kT} \right]$$
 Where $C = \frac{Bl}{A}$

Taking log on both sides $\ln R = \ln C + \frac{E_g}{2kT}$

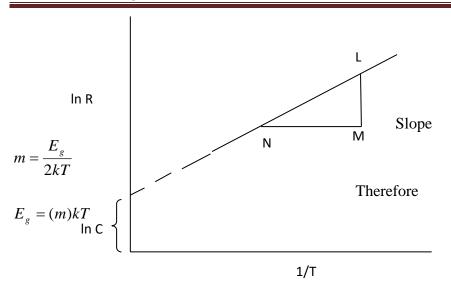
Therefore
$$\frac{E_g}{2kT} = (\ln R - \ln C)$$

The band gap is given by $E_g = 2kT(\ln R - \ln C)$

 $\ln R = \ln C + \frac{E_g}{2kT}$ is of the form y = mx + c: By taking $\ln R$ in the y-

axis and $\frac{1}{T}$ in the x-axis, if a graph is plotted, a straight line is obtained

as shown in below figure.



By finding the slope of the straight line, the band gap of the semiconductor is determined using the relation, $E_g = 2k x$ slope of the straight line drawn between $\ln R$ and 1/T.